

MAX22515

IO-Link Transceiver with Integrated Protection

General Description

The MAX22515 low-power industrial transceiver can operate as either an IO-Link device or a non-IO-Link sensor transceiver in industrial applications. The MAX22515 features a selectable control interface (pin mode or I²C), two integrated linear regulators, and integrated surge protection for robust communication. The transceiver includes one C/Q input-output channel and one digital input (DI) channel.

The device features a flexible control interface. Pin-control logic inputs allow for operation with switching sensors that do not use a microcontroller. For sensors that use a microcontroller, an I²C interface is available providing extensive configuration and diagnostics. Additionally, an integrated oscillator simplifies the clock generation for IO-Link devices.

The MAX22515 features extensive integrated protection to ensure robust communication in harsh industrial environments. All IO-Link line interface pins (V₂₄, C/Q, DI, and GND) are reverse voltage protected, short-circuit protected, hot-plug protected, and feature integrated ±1.2kV/500Ω surge protection.

The MAX22515 is available in a tiny WLP package (2.5mm x 2.0mm) or a 24-pin TQFN-EP package (4mm x 4mm) and operates over the -40°C to +125°C temperature range.

Applications

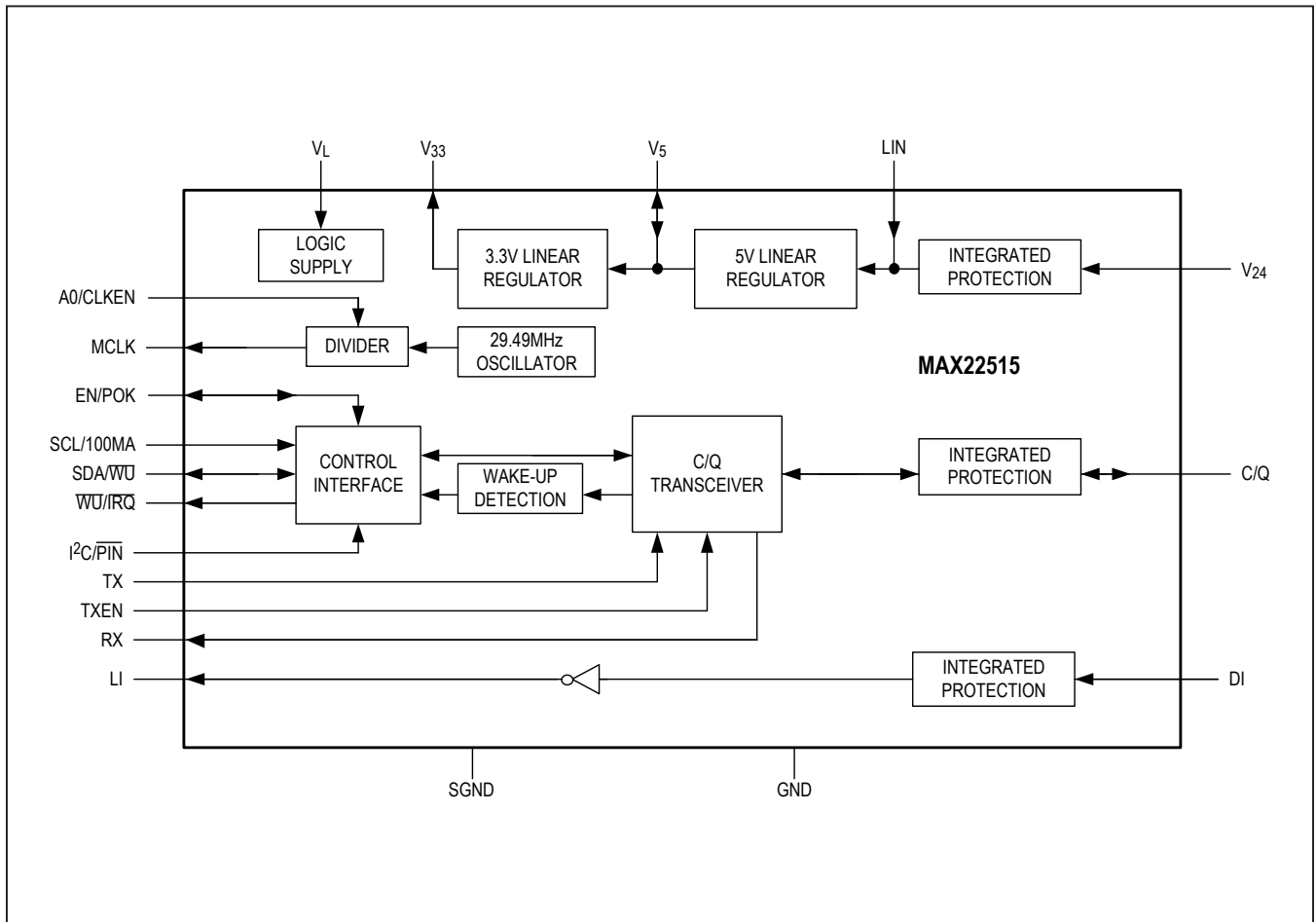
- IO-Link Sensor and Actuator Devices
- Industrial Sensors
- IO-Link Masters

Benefits and Features

- High Configurability and Integration Reduces SKU
 - Operates from 8V to 36V
 - Auxiliary Digital Input (DI)
 - I²C or Pin Mode Control
 - Selectable C/Q Driver Current: 50mA to 250mA
 - Selectable C/Q Driver Slew Rate (I²C Mode)
 - Integrated Oscillator for IO-Link Communication
 - IO-Link Wake-Up Detection and Wake-Up Generation
 - Integrated Linear Regulators: 3.3V and 5V
 - Compatible Register Set to MAX22513
- Integrated Protection Enables Robust Systems
 - ±1.2kV/500Ω Surge Protection on V₂₄, C/Q, DI, and GND
 - Reverse Polarity Protection on V₂₄, C/Q, DI, and GND
 - Hot-Plug Protection on Supply Input (V₂₄)
 - Glitch Filters for Improved Burst Resilience
 - Selectable Driver Overcurrent Configuration
 - -40°C to +125°C Operating Temperature Range
 - Fast Demagnetization of Inductive Loads
- Optimized for Small Designs
 - Low Power Dissipation: 2Ω (typ) C/Q Driver On-Resistance
 - 1.3mA (typ) Supply Current
 - Available in Two Tiny Packages:
 - 20-Bump WLP (2.5mm x 2.0mm)
 - 24-Pin TQFN-EP (4mm x 4mm)

[Ordering Information](#) appears at end of data sheet.

Simplified Block Diagram



Absolute Maximum Ratings

All voltages referenced to GND, unless otherwise noted.

V ₂₄ (Continuous)	-36V to +36V
V ₂₄ (Peak, 100µs)	-52V to +65V
LIN (LIN is connected to V ₂₄ , Continuous)	-36V to +36V
LIN (LIN is connected to V ₂₄ , Peak)	-52V to +65V
LIN	max(-0.3V, V ₅ - 0.3V) to +V ₂₄
C/Q (Continuous)	max(-36V, V ₂₄ - 36V) to min(+36V, (V ₂₄ + 36V))
C/Q (Peak, 100µs)	max(-52V, V ₂₄ - 52V) to min (+52V, V ₂₄ + 52V)
DI (Continuous)	-36V to +36V
DI (Peak, 100µs)	-52V to +52V
V ₅ , V _L	-0.3V to +6V
V ₃₃	-0.3V to (V ₅ + 0.3V)
LOGIC PINS	
I ² C/PIN, EN/POK, CLKEN, SCL/100MA, SDA/WU, WU/IRQ, TXEN, TX	-0.3V to +6V

MCLK, RX, LI	-0.3V to (V _L + 0.3)V
SGND	-0.3V to +0.3V
Continuous Current into V ₂₄ and GND	±1A
Continuous Current into LIN	±100mA
Continuous Current into C/Q	±500mA
Continuous Current into V ₅ and V ₃₃	±60mA
Continuous Current into Any Other Pin	±50mA
Continuous Power Dissipation 24-Pin TQFN (T _A = +70°C)	2222mW
(derate at 27.8mW/°C above +70°C)	
20-bump WLP (T _A = +70°C)	1700mW
(derate at 21.35mW/°C above +70°C)	
Operating Temperature Range	-40°C to +125°C
Maximum Junction Temperature	+160°C
Storage Temperature Range	-65°C to +150°C
Soldering Temperature (TQFN only, 10 sec)	+300°C
Bump Reflow Temperature	+260°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Package Information

PACKAGE TYPE: 24 TQFN-EP

PACKAGE CODE	T2444+4
Outline Number	21-0139
Land Pattern Number	90-0022
Thermal Resistance, Single-Layer Board:	
Junction to Ambient (θ _{JA})	48°C/W
Junction to Case (θ _{JC})	3°C/W
Thermal Resistance, Four-Layer Board:	
Junction to Ambient (θ _{JA})	36°C/W
Junction to Case (θ _{JC})	3°C/W

PACKAGE TYPE: 20 (5 x 4) WLP

PACKAGE CODE	W201L2+1
Outline Number	21-100314
Land Pattern Number	Refer to Application Note 1891
Thermal Resistance, Four-Layer Board:	
Junction to Ambient (θ _{JA})	46.83°C/W

For the latest package outline information and land patterns (footprints), go to www.maximintegrated.com/packages. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maximintegrated.com/thermal-tutorial.

DC Electrical Characteristics

(V_{24} = 8V to 36V, V_5 = 4.5V to 5.5V, V_L = 2.5V to 5.5V, All logic inputs at V_L or GND, T_A = -40°C to +125°C, unless otherwise noted. Typical values are at V_{24} = 24V, V_5 = 5V, V_L = 3.3V, and T_A = +25°C, unless otherwise noted.) (Notes 1, 2)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
DC ELECTRICAL CHARACTERISTICS / POWER SUPPLY							
V_{24} Supply Voltage	V_{24}			8		36	V
V_{24} Undervoltage Lockout Threshold	V_{24UVLO}	V_{24} rising		6.9	7.5	8	V
		V_{24} falling		6.4	6.9	7.5	
V_{24} Undervoltage Lockout Threshold Hysteresis	V_{24UVLO_HYST}				500		mV
V_{24} Low Voltage Warning Threshold	V_{24_W}	V_{24} falling		14.5	15.3	16.3	V
V_{24} Supply Current	I_{24}	V_5 powered externally, no load on C/Q	C/Q is high impedance		16	30	μ A
			C/Q is in push-pull and is high or low		285	400	
V_5 Supply Voltage	V_5	LIN = V_5 , V_5 supplied externally		4.5		5.5	V
V_5 Undervoltage Lockout Threshold	V_{5UVLO}	V_5 rising				3.5	V
		V_5 falling		3			
V_5 Supply Current	I_5	LIN = V_5 , V_5 powered externally, no load on V_{33} , no load on C/Q	C/Q is high impedance, V_{33} disabled, MCLK disabled		560	850	μ A
			C/Q is in push-pull mode and is high or low, V_{33} enabled, MCLK disabled		1.08	1.5	mA
			C/Q is in push-pull mode and is high or low, V_{33} enabled, MCLK enabled		1.5	2.2	
V_L Logic Level Supply Voltage	V_L			2.5		5.5	V
V_L Undervoltage Threshold	V_{LUVLO}	V_L rising		0.5	0.85	1.2	V
V_L Logic Level Supply Current	I_{VL}	All logic inputs at GND or V_L , no load on any logic output	MCLK disabled		1	10	μ A
			MCLK enabled, $f = 29.49$ MHz		800		
			MCLK enabled, 10pF load on MCLK, $V_L = 3.3$ V, $f = 29.49$ MHz		1.56		mA
DC ELECTRICAL CHARACTERISTICS / 5V LINEAR REGULATOR (V_5)							
V_5 Input Supply Voltage	V_{LIN}			8		36	V
V_5 Output Voltage	V_5	$8V \leq V_{LIN} \leq 36V$, no load on V_5		4.9	5	5.1	V
V_5 Load Regulation	ΔV_{5_LDR}	$V_{LIN} = 24V$, $1mA \leq I_{LOAD} \leq 50mA$			0.8	2	%
V_5 Line Regulation	ΔV_{5_LNR}	$8V \leq V_{LIN} \leq 36V$, $I_{LOAD} = 1mA$			0.007	0.3	mV/V
V_5 Power Supply Rejection Ratio (PSRR)	$PSRR_{V5}$	$f = 100kHz$, $I_{LOAD} = 20mA$			-65		dB
V_5 Load Capacitance	C_{V5}	External capacitance required on V_5		0.8	1		μ F

DC Electrical Characteristics (continued)

($V_{24} = 8V$ to $36V$, $V_5 = 4.5V$ to $5.5V$, $V_L = 2.5V$ to $5.5V$, All logic inputs at V_L or GND, $T_A = -40^\circ C$ to $+125^\circ C$, unless otherwise noted. Typical values are at $V_{24} = 24V$, $V_5 = 5V$, $V_L = 3.3V$, and $T_A = +25^\circ C$, unless otherwise noted.) (Notes 1, 2)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
DC ELECTRICAL CHARACTERISTICS / 3.3V LINEAR REGULATOR (V_{33})							
V_{33} Output Voltage	V_{33}	No load		3.22	3.32	3.42	V
V_{33} Load Regulation	ΔV_{33_LR}	$1mA \leq I_{LOAD} \leq 50mA$			0.1	0.8	%
V_{33} Load Capacitance	C_{V33}	External capacitance required on V_{33}		0.8	1		μF
DC ELECTRICAL CHARACTERISTICS / C/Q DRIVER							
C/Q Driver On-Resistance	R_{OH}	High-side enabled, $CL[1:0] = 11$, $I_{LOAD} = -200mA$ (Note 3)			2.65	4.6	Ω
	R_{OL}	Low-side enabled, $CL[1:0] = 11$, $I_{LOAD} = +200mA$ (Note 3)			2.2	4.2	
C/Q Driver Current Limit	I_{CL}	$V_{DROP} = 3V$ (Note 4)	$CL[1:0] = 00$	50	66	80	mA
			$CL[1:0] = 01$ (I ² C mode) or SDA/100MA = high (pin mode)	100	120	140	
			$CL[1:0] = 10$ (I ² C mode) or SDA/100MA = low (pin mode)	210	240	270	
			$CL[1:0] = 11$	260	300	340	
C/Q Leakage Current	I_{LEAK_CQ}	I ² C mode only, $V_{24} = 24V$, $(V_{24} - 36V) \leq V_{C/Q} \leq 36V$, C/Q driver and receiver disabled ($CQ_EN = 0$, $RXDIS = 1$)		-40		+30	μA
		C/Q driver disabled ($CQ_EN = 0$), $V_{24} = 24V$, $0 \leq V_{C/Q} \leq (V_{24} - 0.5V)$		-2		+2	
C/Q Output Reverse Current	I_{REV_CQ}	C/Q driver enabled ($TXEN = high$, $CQ_EN = 1$) and in push-pull ($CQ_PP = 1$), $V_{C/Q} = (V_{24} + 5V)$ or ($V_{GND} - 5V$)		-90		+300	μA
C/Q Weak Pulldown Current	I_{PD}	I ² C mode only, $V_{C/Q} > 5V$, $TXEN = low$, $CQ_EN = 1$, $CQ_PD = 1$, $CQ_PU = 0$		+230	+320	+400	μA
C/Q Weak Pullup Current	I_{PU}	I ² C mode only, $V_{C/Q} = (V_{24} - 5V)$, $TXEN = low$, $CQ_EN = 1$, $CQ_PD = 0$, $CQ_PU = 1$		-400	-300	-230	μA
DC ELECTRICAL CHARACTERISTICS / C/Q, DI RECEIVER							
Input Voltage Range	V_{IN}	For valid RX/LI logic		V_{24} -36		36	V
Input Threshold High	V_{TH}	TXEN = low	$V_{24} \geq 18V$	10.8		12.5	V
			$V_{24} < 18V$	57.5		72	% of V_{24}
Input Threshold Low	V_{TL}	TXEN = low	$V_{24} \geq 18V$	8.8		10.5	V
			$V_{24} < 18V$	45		63	% of V_{24}

DC Electrical Characteristics (continued)

(V_{24} = 8V to 36V, V_5 = 4.5V to 5.5V, V_L = 2.5V to 5.5V, All logic inputs at V_L or GND, T_A = -40°C to +125°C, unless otherwise noted. Typical values are at V_{24} = 24V, V_5 = 5V, V_L = 3.3V, and T_A = +25°C, unless otherwise noted.) (Notes 1, 2)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Input Hysteresis	V_{HYS}	TXEN = low	$V_{24} \geq 18V$		2		V
			$V_{24} < 18V$		11		% of V_{24}
C/Q Input Capacitance	C_{IN_CQ}	Driver disabled, CQ_EN = 0, RXDIS = 0, CQ_PD = 0, CQ_PU = 0, f = 100kHz			45		pF
DI Input Capacitance	C_{IN_DI}	DIDIS = 0, LIDIS = 0, f = 100kHz			4		pF
DI Input Current	I_{DI_IN}	$V_{24} = 24V$, DI receiver enabled, ($V_{24} - 36V$) $\leq V_{DI} \leq 36V$		-10		+15	μA
DC ELECTRICAL CHARACTERISTICS / LOGIC INPUTS (A0/CLKEN, SCL/100MA, SDA/WU, TXEN, TX, I²C/PIN, EN/POK)							
Logic Input Voltage Low	V_{IL}					$0.2 \times V_L$	V
Logic Input Voltage High	V_{IH}			$0.7 \times V_L$			V
Logic Input Leakage Current	I_{LEAK}	A0/CLKEN, SCL/100MA, SDA/WU, TXEN, TX, I ² C/PIN, Logic input = GND or V_L		-1		+1	μA
EN/POK Input Pullup Resistance	R_{PU}	EN/POK		60	100	140	k Ω
DC ELECTRICAL CHARACTERISTICS / LOGIC OUTPUTS (WU/IRQ, MCLK, SDA/WU, RX, LI)							
Logic Output Voltage Low	V_{OL}	LI, RX, MCLK, SDA/WU, $I_{LOAD} = +5mA$				0.15	V
Logic Output Voltage High	V_{OH}	LI, RX, MCLK, $I_{LOAD} = -5mA$		$V_L - 0.2$			V
Open-Drain High Impedance Leakage Current	I_{LK_OD}	WU/IRQ, output not asserted		-1		+1	μA
Logic Output Leakage Current	I_{LKG_OUT}	RX, LI, MCLK	DIDIS = 1, RXDIS = 1, MCLKDIS = 1, Logic output = GND or V_L	-1		+1	μA
SDA/WU Leakage Current	I_{LK_SDA}			-1		+1	μA
DC ELECTRICAL CHARACTERISTICS / THERMAL MANAGEMENT							
C/Q Driver Shutdown Temperature	T_{SHUT_D}	Driver temperature rising, C/Q driver fault bit is set and driver is disabled			+150		°C
C/Q Driver Shutdown Hysteresis	T_{SHUT_DHYS}	Driver temperature falling, C/Q driver is automatically reenabled			10		°C
IC Thermal Warning Threshold	T_{WRN}	Die temperature rising, THERMW and THERMWINT bits are set			+140		°C
IC Thermal Warning Threshold Hysteresis	T_{WRN_HYS}	Die temperature falling, THERMW bit is cleared			15		°C
IC Junction Thermal Shutdown Threshold	T_{SHUT_IC}	Die temperature rising			+160		°C
IC Junction Thermal Shutdown Hysteresis	T_{SHUT_ICHYS}	Die temperature falling			15		°C

AC Electrical Characteristics

($V_{24} = 8V$ to $36V$, $V_5 = 4.5V$ to $5.5V$, $V_L = 2.5V$ to $5.5V$, All logic inputs at V_L or GND, $T_A = -40^\circ C$ to $+125^\circ C$, unless otherwise noted. Typical values are at $V_{24} = 24V$, $V_5 = 5V$, $V_L = 3.3V$, and $T_A = +25^\circ C$, unless otherwise noted.) (Notes 1, 2)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
AC ELECTRICAL CHARACTERISTICS / C/Q DRIVER							
C/Q Driver Low-to-High Propagation Delay	t_{PDLH_PP}	CQSLEW[1:0] = 00, Figure 1	Push-pull or PNP mode	0.5	0.75	μs	
	t_{PDLH_OC}		NPN mode	1			
C/Q Driver High-to-Low Propagation Delay	t_{PDHL_PP}	CQSLEW[1:0] = 00, Figure 1	Push-pull or NPN mode	0.45	0.75	μs	
	t_{PDHL_OC}		PNP mode	1			
C/Q Driver Skew	t_{SKEW}	$ t_{PDLH} - t_{PDHL} $, CQSLEW[1:0] = 00	-0.25	0.05	+0.25	μs	
C/Q Driver Rise Time	t_{RISE}	Push-pull or PNP mode, $V_{24(max)} = 30V$, Figure 1	CQSLEW[1:0] = 00	0.05	0.15	0.3	μs
			CQSLEW[1:0] = 01 (I ² C mode) or when in pin mode	0	0.3	0.84	
			CQSLEW[1:0] = 10	0.45	0.9	1.4	
			CQSLEW[1:0] = 11	1.5	3.3	6	
C/Q Driver Fall Time	t_{FALL}	Push-pull or NPN mode, $V_{24(max)} = 30V$, Figure 1	CQSLEW[1:0] = 00	0.05	0.16	0.3	μs
			CQSLEW[1:0] = 01 (I ² C mode) or when in pin mode	0.15	0.33	0.5	
			CQSLEW[1:0] = 10	0.45	0.8	1.3	
			CQSLEW[1:0] = 11	1.5	3.3	6	
Difference in C/Q Rise and Fall Time		$ t_{RISE} - t_{FALL} $, Push-pull mode, $V_{24(max)} = 30V$	CQSLEW[1:0] = 00	0.01		μs	
			CQSLEW[1:0] = 01 or when in pin mode	0.03			
			CQSLEW[1:0] = 10	0.1			
			CQSLEW[1:0] = 11	0			
C/Q Driver Enable Time High	t_{ENH}	Push-pull or NPN configuration, Figure 2		0.5	0.75	μs	
C/Q Driver Enable Time Low	t_{ENL}	Push-pull or PNP configuration, Figure 3		0.2	0.4	μs	
C/Q Driver Disable Time High	t_{DISH}	Push-pull or NPN configuration, Figure 2		1.8		μs	
C/Q Driver Disable Time Low	t_{DISL}	Push-pull or PNP configuration, Figure 3		1.8		μs	

AC Electrical Characteristics (continued)

($V_{24} = 8V$ to $36V$, $V_5 = 4.5V$ to $5.5V$, $V_L = 2.5V$ to $5.5V$, All logic inputs at V_L or GND, $T_A = -40^\circ C$ to $+125^\circ C$, unless otherwise noted. Typical values are at $V_{24} = 24V$, $V_5 = 5V$, $V_L = 3.3V$, and $T_A = +25^\circ C$, unless otherwise noted.) (Notes 1, 2)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
AC ELECTRICAL CHARACTERISTICS / C/Q, DI RECEIVER							
C/Q Receiver Low-to-High Propagation Delay	t_{PRLH_CQ}	Figure 4	RXFILTER = 1	0.85	1.35	1.8	μs
			RXFILTER = 0	0.25	0.38	0.55	
C/Q Receiver High-to-Low Propagation Delay	t_{PRHL_CQ}	Figure 4	RXFILTER = 1	0.85	1.28	1.8	μs
			RXFILTER = 0	0.2	0.3	0.5	
C/Q Receiver Skew			RXFILTER = 1	70		ns	
			RXFILTER = 0	70			
DI Receiver Low-to-High Propagation Delay	t_{PRLH_DI}	Figure 4	DIFILTER = 1	1.2	1.8	2.4	μs
			DIFILTER = 0	0.6	0.9	1.2	
DI Receiver High-to-Low Propagation Delay	t_{PRHL_DI}	Figure 4	DIFILTER = 1	1.2	1.7	2.4	μs
			DIFILTER = 0	0.5	0.75	1.1	
AC ELECTRICAL CHARACTERISTICS / WAKE-UP DETECTION (Figure 5)							
Wake-Up Input Minimum Pulse Width	t_{WUMIN}	$C_{LOAD} = 3nF$	60	66	70	μs	
Wake-Up Input Maximum Pulse Width	t_{WUMAX}	$C_{LOAD} = 3nF$	85	95	110	μs	
SDA/WU (Pin mode)/WU/ \overline{IRQ} (I ² C Mode) Output Low Time	t_{WUL}	Valid wake-up condition on C/Q (Note 5)	150	200	250	μs	
AC ELECTRICAL CHARACTERISTICS / WAKE-UP GENERATION (I²C mode only, Figure 6)							
Setup Time before Wake-Up	t_{SU_WU}			80		μs	
Wake-Up Pulse Duration	t_{WU}	Wake-up pulse has opposite polarity of the existing C/Q level	75	80	85	μs	
On-Time after Wake-Up	t_{ON_WU}	C/Q driver enabled with original polarity after t_{WU}		2		μs	
High Impedance Time after Wake-Up	t_{DIS_WU}	C/Q driver is high impedance after t_{ON_WU}		418		μs	
C/Q Driver Current Limit During Wake-Up Pulse	I_{WU}		500			mA	
AC ELECTRICAL CHARACTERISTICS / MCLK CLOCK TIMING							
MCLK Frequency	f_{MCLK}	CLKDIV[2:0] = 000	3.612	3.686	3.761	MHz	
		CLKDIV[2:0] = 001	7.225	7.373	7.523		
		CLKDIV[2:0] = 010	14.45	14.74	15.05		
		CLKDIV[2:0] = 011	28.90	29.49	30.09		
		CLKDIV[2:0] = 100	1.806	1.843	1.881		
MCLK Duty Cycle	D_{MCLK}			50		%	

AC Electrical Characteristics (continued)

($V_{24} = 8V$ to $36V$, $V_5 = 4.5V$ to $5.5V$, $V_L = 2.5V$ to $5.5V$, All logic inputs at V_L or GND, $T_A = -40^\circ C$ to $+125^\circ C$, unless otherwise noted. Typical values are at $V_{24} = 24V$, $V_5 = 5V$, $V_L = 3.3V$, and $T_A = +25^\circ C$, unless otherwise noted.) (Notes 1, 2)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
AC ELECTRICAL CHARACTERISTICS / I²C TIMING SPECIFICATIONS (Figure 7)						
Maximum I ² C Clock Frequency	f_{I2CCLK}				2	MHz
Maximum Clock Period	t_{SCLMAX}		100			μs
Bus Free Time Between STOP and START Conditions	t_{I2CBUF}		0.16			μs
START Condition Setup Time	$t_{I2CSUSTA}$		0.05			μs
Repeat START Condition Setup Time	$t_{I2CSUSTA}$	90% to 90%	0.05			μs
START Condition Hold Time	$t_{I2CHDSTA}$	10% of SDA/ \overline{WU} to 90% of SCL/100MA	0.09			μs
STOP Condition Setup Time	$t_{I2CSUSTO}$	90% of SCL/100MA to 10% of SDA/ \overline{WU}	0.05			μs
Clock Low Period	t_{I2CLOW}	10% to 10%	0.12			μs
Clock High Period	$t_{I2CHIGH}$	90% to 90%	0.18			μs
Data Valid to SCL/100MA Rise Time	$t_{I2CSUDAT}$	Write Setup Time	50			ns
Data Hold Time	$t_{I2CHDDAT}$	Write Hold Time			0	ns
Maximum SDA/ \overline{WU} Drive Low Time	t_{DATLOW}		1.0	1.1	1.2	ms
ESD AND EMC TOLERANCE						
ESD Protection (V_{24} , C/Q, DI Pins)		IEC 61000-4-2 Contact Discharge, 500pF load on C/Q, 1.5k Ω in series with DI		± 4		kV
ESD Protection (All Other Pins)		Human Body Model		± 2		kV
Surge Protection (V_{24} , C/Q, DI, GND Pins)	V_{SRG}	IEC 61000-4-5, 500 Ω , 8/20 μs surge		± 1.2		kV

Note 1: All devices 100% production tested at $T_A = +25^\circ C$. Limits over operating temperature range are guaranteed by design.

Note 2: Currents out of the device are negative. Currents into the device are positive.

Note 3: Not production tested. Guaranteed by design.

Note 4: V_{DROP} is measured as the voltage from the driver output to GND ($V_{DRIVER} - V_{GND}$) when measuring the low-side driver-current limit and as ($V_{24} - V_{DRIVER}$) when measuring the high-side current limit.

Note 5: SDA/ \overline{WU} always asserts when a valid wake-up condition is received when operating in pin mode. When operating the device in I²C mode, $\overline{WU}/\overline{IRQ}$ asserts for t_{WUUL} only when no interrupts have been registered (INTERRUPT register) and the $WUM = 1$ in the IRQMASK register. If $WUM = 0$, $WUINT$ is set when a valid wake-up event is detected and $\overline{WU}/\overline{IRQ}$ asserts until the INTERRUPT register is read.

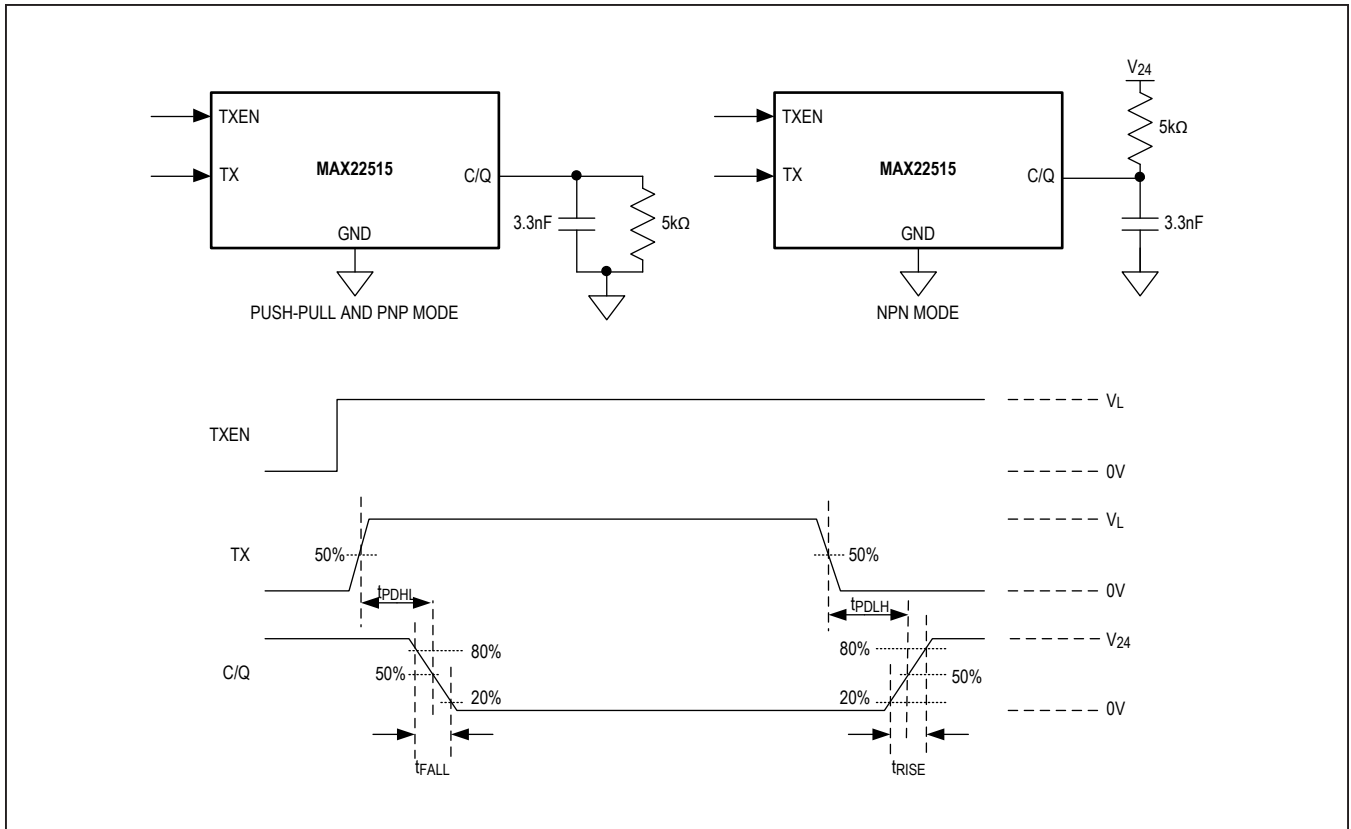


Figure 1. C/Q Driver Propagation Delays

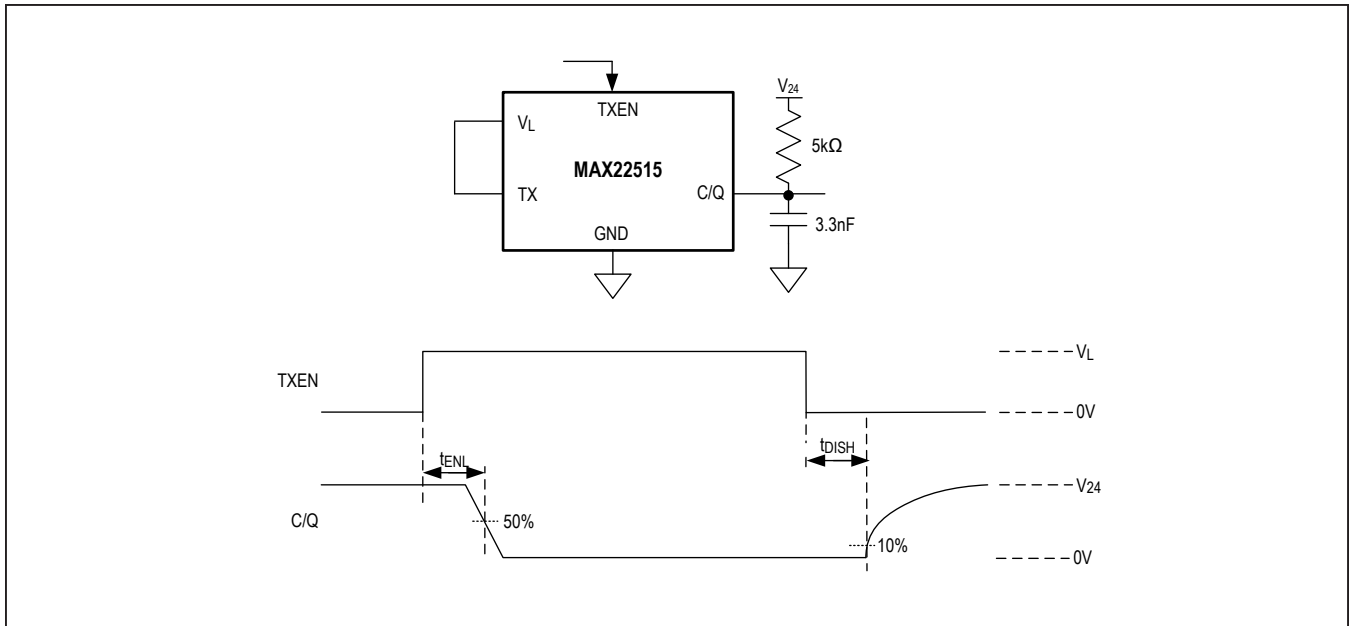


Figure 2. C/Q Driver Enable Low and Disable High Timing

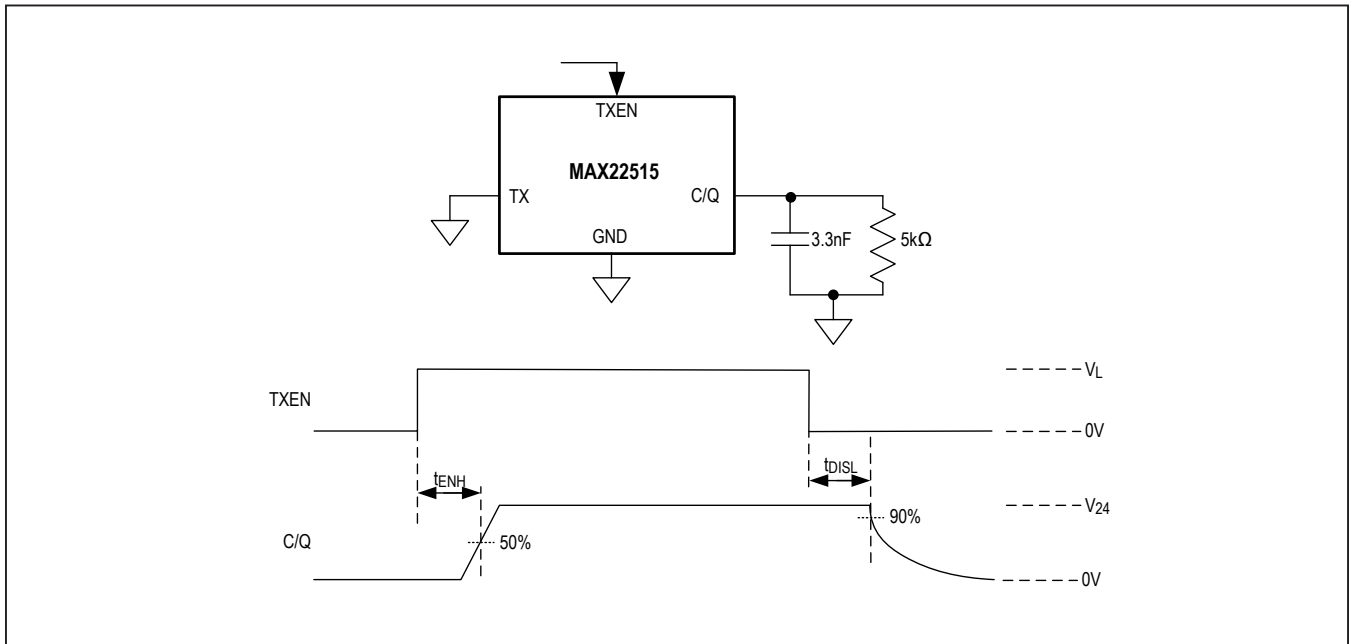


Figure 3. C/Q Driver Enable Time High and Disable Time Low

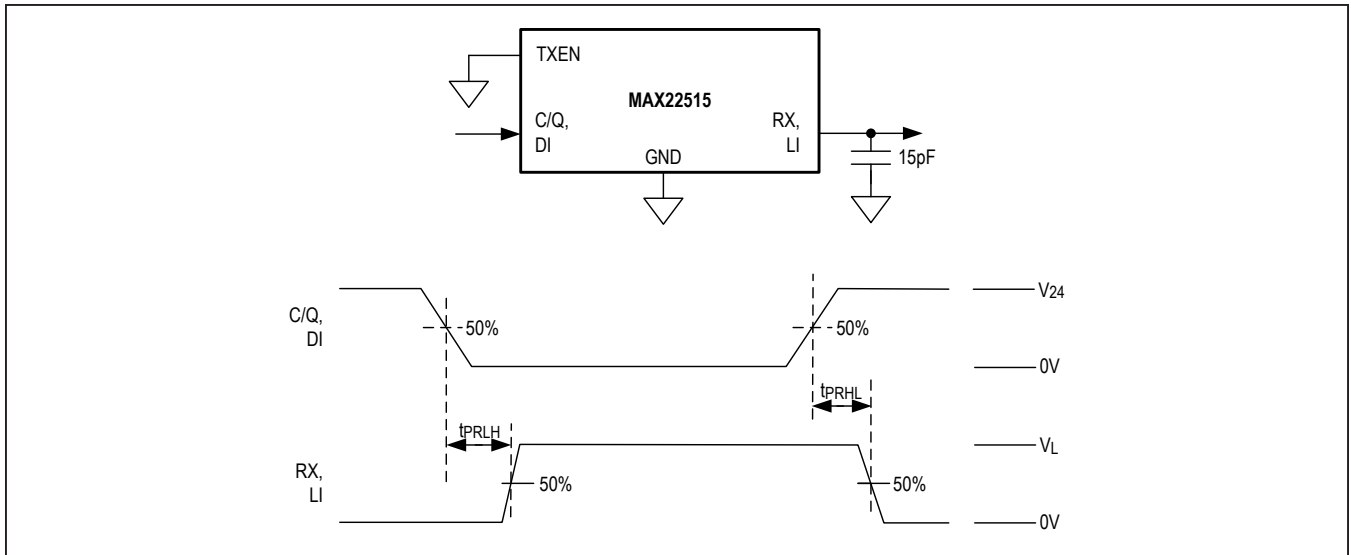


Figure 4. C/Q and DI Receiver Timing

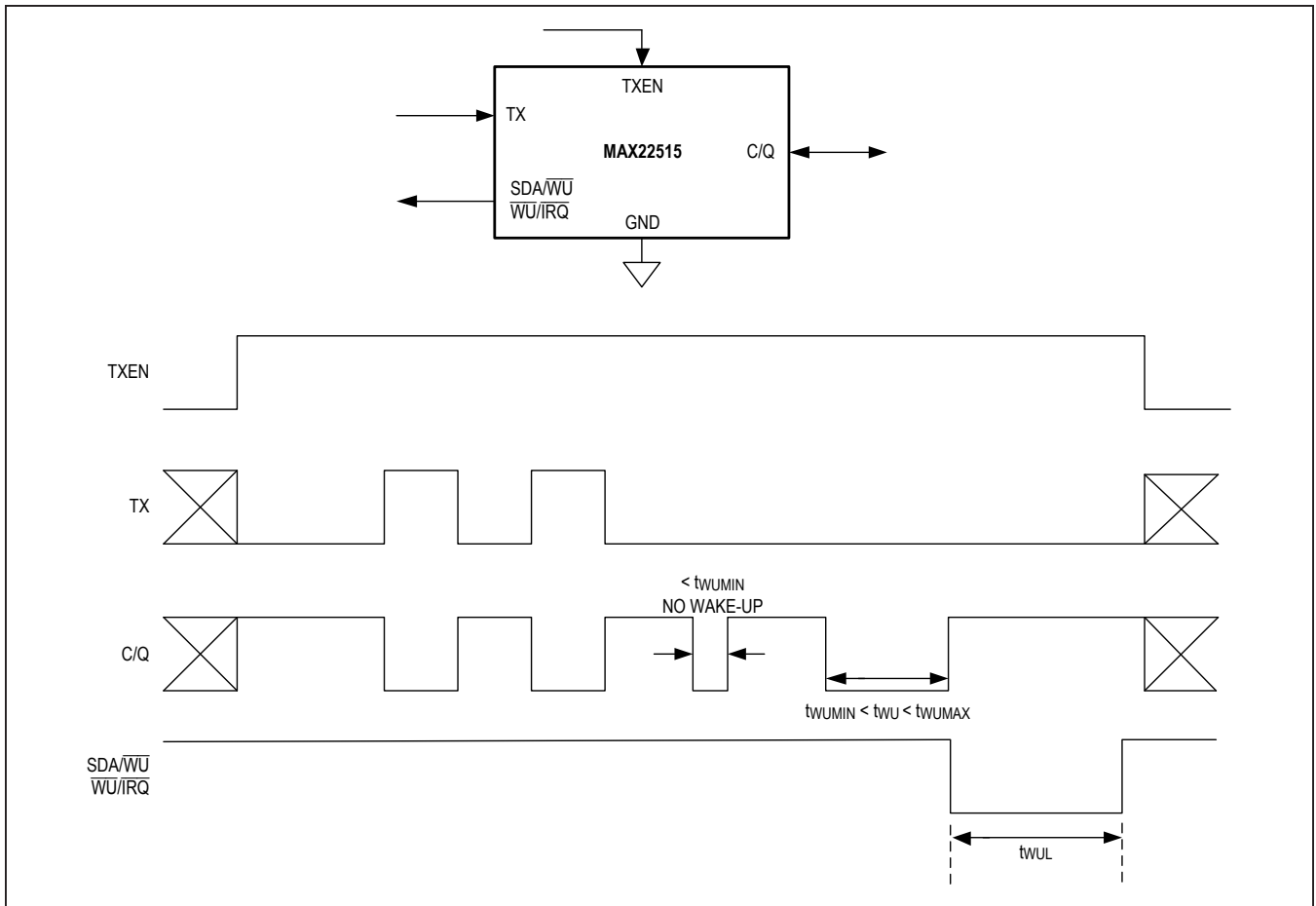
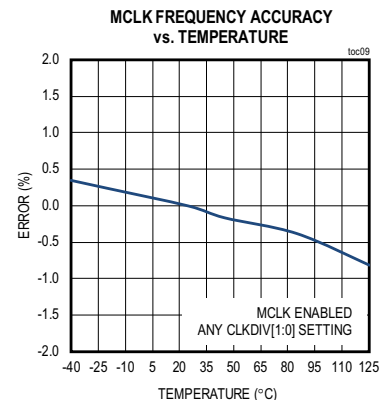
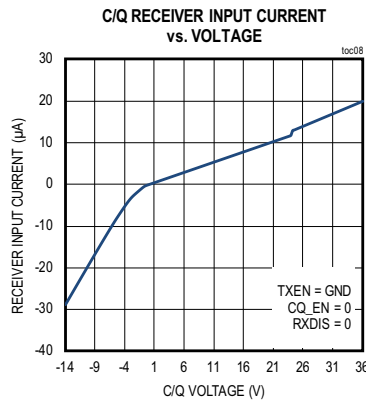
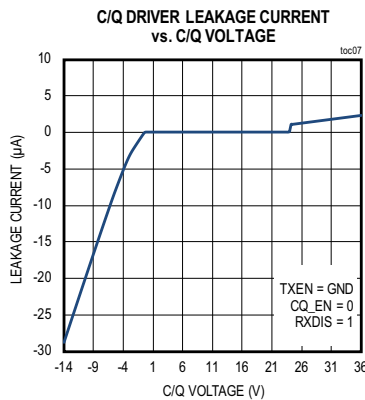
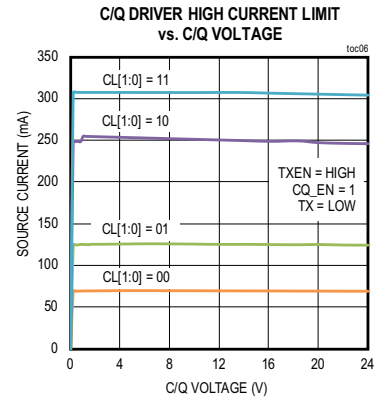
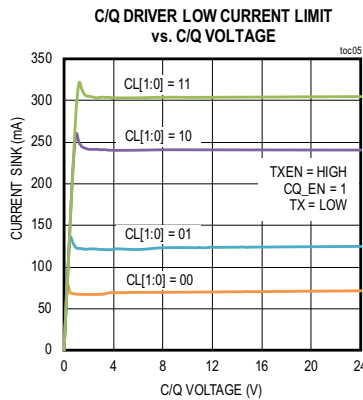
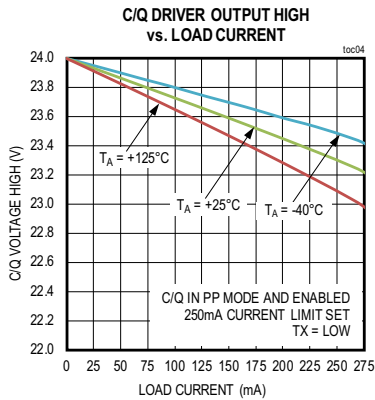
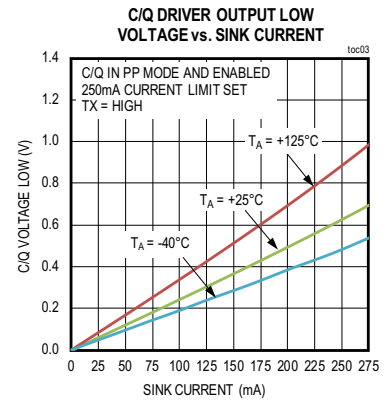
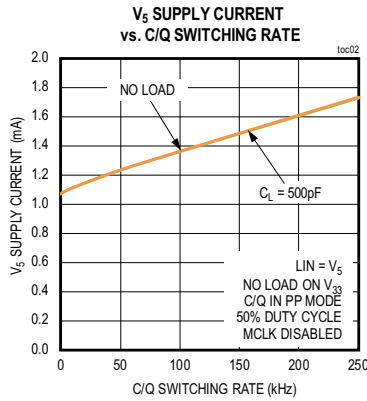
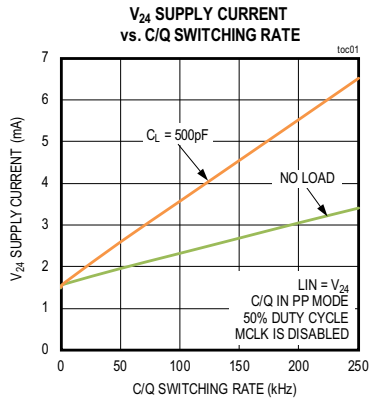


Figure 5. Wake-Up Detection Timing

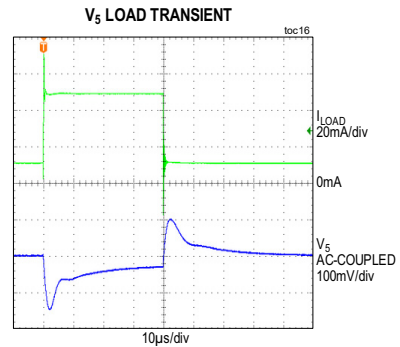
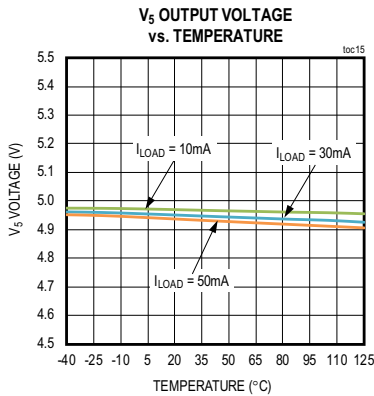
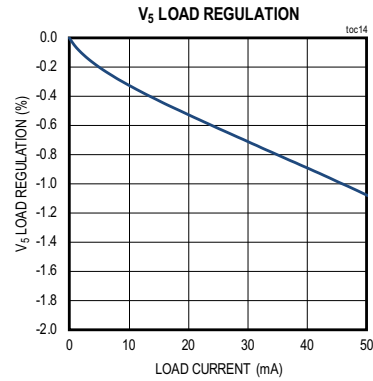
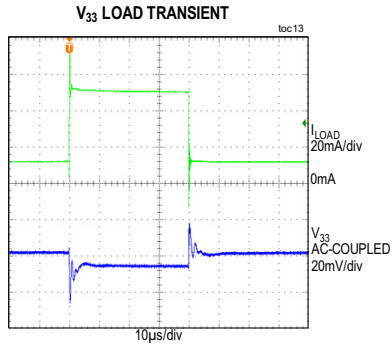
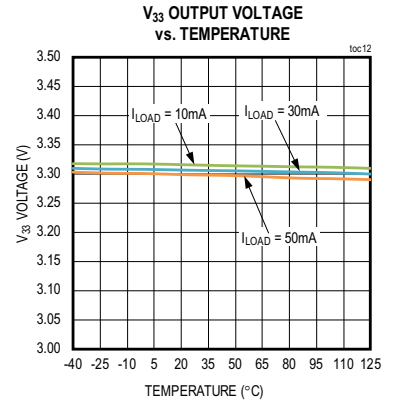
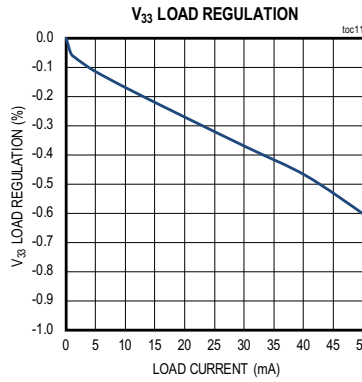
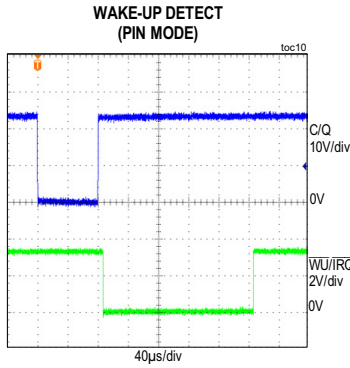
Typical Operating Characteristics

V₂₄ = 24V, LIN is connected to V₂₄, V_L = V₃₃, T_A = 25°C, unless otherwise noted.

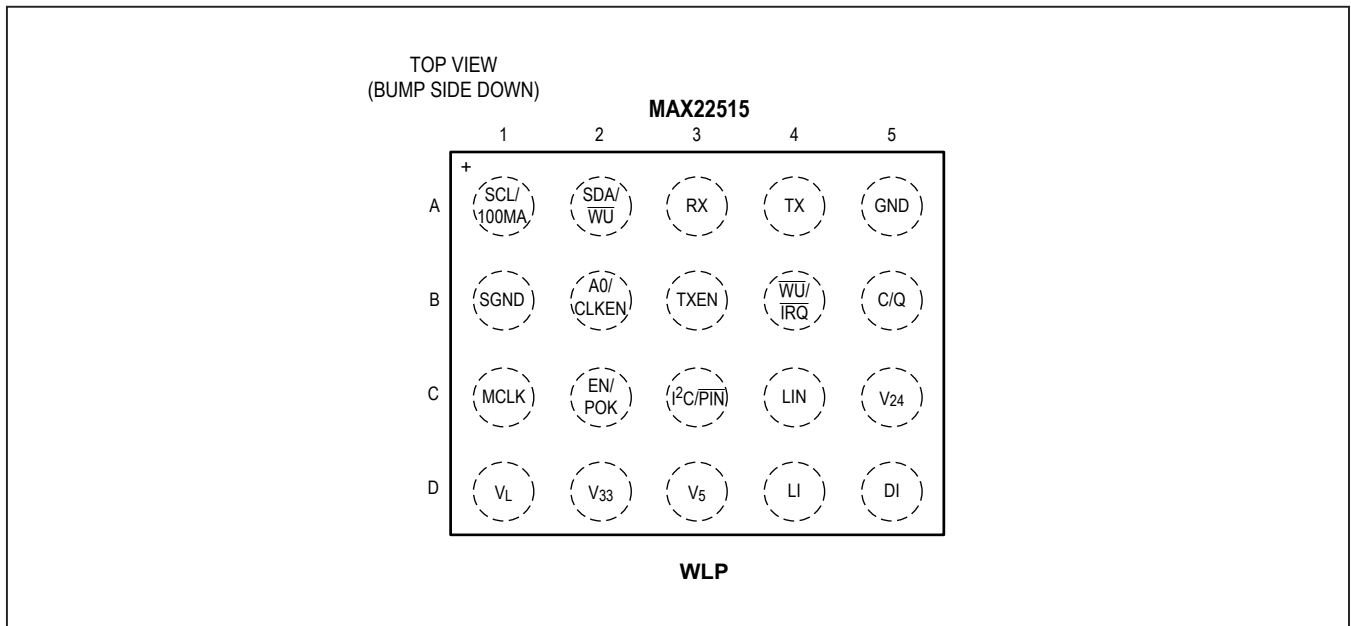
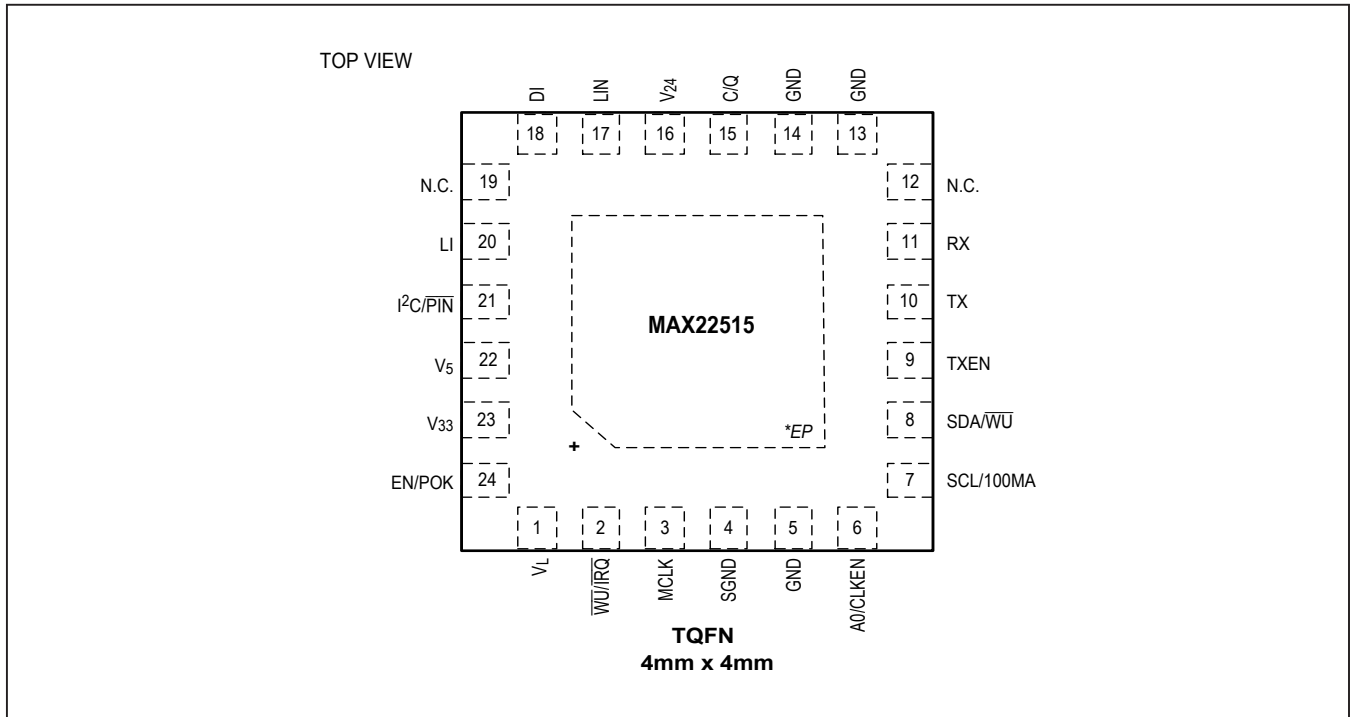


Typical Operating Characteristics (continued)

$V_{24} = 24V$, LIN is connected to V_{24} , $V_L = V_{33}$, $T_A = 25^\circ C$, unless otherwise noted.



Pin Configurations



Pin Description

PIN		NAME	FUNCTION
TQFN	WLP		
POWER			
1	D1	V _L	Logic Supply Input. Bypass V _L to GND with a 0.1μF capacitor as close to the device as possible. V _L sets the logic level for all logic signals. Connect V _L to V ₃₃ , V ₅ , or to an external voltage between 2.5V and 5V.
4	B1	SGND	Signal Ground. Connect SGND to GND.
5, 13, 14	A5	GND	Ground
16	C5	V ₂₄	Supply Voltage Input. Apply a 24V (typ) supply to V ₂₄ . Bypass V ₂₄ to GND with a 10nF capacitor as close to the device as possible.
17	C4	LIN	5V Linear Regulator Input. Bypass LIN to GND with a 10nF capacitor as close to the device as possible. Connect LIN to V ₂₄ or to an external supply between 8V and 36V. Short LIN to V ₅ to disable the internal regulator. Connect 5V to LIN and V ₅ when the internal regulator is disabled.
22	D3	V ₅	5V Linear Regulator Output/Supply Input. Bypass V ₅ to GND with a 1μF capacitor as close to the device as possible. V ₅ is the output of the internal 5V linear regulator. To disable the internal regulator, connect LIN to V ₅ . 5V is required on V ₅ for normal operation. If the 5V regulator is disabled, apply an external 5V power supply to V ₅ .
23	D2	V ₃₃	3.3V Linear Regulator Output. Bypass V ₃₃ to GND with a 1μF capacitor as close to the device as possible. V ₃₃ is not required for normal operation.
EP	—	EP	Exposed Pad (TQFN Only). Connect EP to GND.
24V LINE INTERFACE			
15	B5	C/Q	IO-Link Transceiver Input/Output. I ² C Mode: C/Q is disabled at startup. Set CQ_EN = 1 and drive TXEN high to enable the C/Q driver. Pin mode: Drive TXEN high to enable the C/Q driver.
18	D5	DI	Auxiliary Digital Input. I ² C Mode: DI is enabled at power-up. Disable DI by setting the DIDIS bit in the CONTROL register. Pin mode: DI is enabled and cannot be disabled.
CONTROL INTERFACE			
2	B4	$\overline{WU/IRQ}$	IO-Link Wake-Up Detection/Interrupt Open-Drain Output. I ² C Mode: $\overline{WU/IRQ}$ asserts low when a valid IO-Link wake-up is detected on the C/Q line or when a bit in the INTERRUPT register is set. Pin mode: $\overline{WU/IRQ}$ asserts low when a thermal or overcurrent fault occurs. $\overline{WU/IRQ}$ deasserts when the fault is no longer present.
6	B2	A0/CLKEN	I ² C Address Select/MCLK Enable Input. I ² C Mode: Connect A0/CLKEN high or low to set the I ² C address for the MAX22515. See the I²C Controller Interface section for more information. Pin mode: Drive A0/CLKEN high to enable the clock output on MCLK. Drive A0/CLKEN low to disable the clock output. MCLK is 14.74MHz (typ) in pin mode. MCLK is high impedance when disabled.
7	A1	SCL/100MA	I ² C Serial Clock/C/Q Driver Current Limit Setting Input. I ² C Mode: I ² C interface clock input. Pin mode: Drive SCL/100MA high to set the C/Q driver current limit to 100mA (min). Drive SCL/100MA low to set the driver current limit to 200mA (min).

Pin Description (continued)

PIN		NAME	FUNCTION
TQFN	WLP		
8	A2	SDA/WU	I ² C Serial Data Input/Output/Wake-Up Detection Output. I ² C Mode: I ² C serial data input/output. Pin mode: SDA/WU asserts when a valid IO-Link wake-up is detected on the C/Q line.
20	D4	LI	DI Receiver Logic Output. The DI receiver is enabled by default. I ² C Mode: LI is inverted relative to the logic state of DI by default. Set the LIDIS bit in the CONTROL register to disable the LI output. LI is high impedance when LIDIS = 1. Pin mode: LI is inverted relative to the logic state of DI by default. LI cannot be disabled.
21	C3	I ² C/PIN	I ² C or Pin Mode Control Interface Selection Input. Connect I ² C/PIN high to configure and monitor the MAX22515 with the I ² C interface. Connect I ² C/PIN low to configure the MAX22515 for pin mode control.
24	C2	EN/POK	Dual Function Enable Input and Open-Drain Power-OK (POK) Output. Connect EN/POK to V _L with a 10kΩ resistor. Enable Input: Drive EN/POK high to enable the MAX22515 for normal operation. Drive EN/POK low to disable the device. The C/Q driver is disabled and registers are reset (when using I ² C mode) when EN/POK is low. POK Output: The MAX22515 drives EN/POK low when the V ₅ voltage falls below 3V. The C/Q driver is disabled and registers are reset (when using I ² C mode) when EN/POK is low. The MAX22515 releases EN/POK when the V ₅ voltage rises above the 3.5V threshold.
UART INTERFACE			
9	B3	TXEN	C/Q Driver Enable Logic Input. Connect TXEN to the RTS output of a microcontroller for IO-Link communication. I ² C Mode: Set CQ_EN = 1 and drive TXEN high to enable the C/Q driver. Pin mode: Drive TXEN high to enable the C/Q driver. Drive TXEN low to disable the driver.
10	A4	TX	C/Q Driver Logic Input. Connect TX to the TX output of a UART for IO-Link communication. I ² C Mode: TX is inverted relative to the logic state of C/Q by default. Pin mode: TX is inverted relative to the logic state of C/Q.
11	A3	RX	C/Q Receiver Logic Output. Connect RX to the RX input of a UART for IO-Link communication. I ² C Mode: RX is inverted relative to the logic state of C/Q by default. Set the RXDIS bit in the CONTROL register to disable RX. RX is high impedance when RXDIS = 1. Pin mode: RX is inverted relative to the logic state of C/Q. RX cannot be disabled.
CLOCK OUTPUT			
3	C1	MCLK	Microcontroller Clock Output. I ² C Mode: Set the MCLK frequency by setting the CLKDIV bits in the CLKCONFIG register. Connect MCLK to an external microcontroller for comparison and trimming. The MCLK frequency is 14.74MHz (typ) by default, but can be disabled or programmed to 3.686MHz, 7.373MHz, 14.74MHz, 29.49MHz, or 1.843MHz. Pin mode: The MCLK frequency is fixed at 14.74MHz (typ). Drive A0/CLKEN high to enable the MCLK output. Drive A0/CLKEN low to disable the MCLK output. MCLK is high impedance when A0/CLKEN is low.
NOT CONNECTED			
12, 19		N.C.	Not connected. Not internally connected.

Detailed Description

The MAX22515 low-power industrial transceiver with integrated surge protection can be configured to operate as either an IO-Link device or in a non-IO-Link industrial sensor. The transceiver includes one IO-Link C/Q bidirectional channel and one digital input (DI) channel.

The MAX22515 features a flexible control interface. Set the device in pin mode control for operation with switching sensors that do not use a microcontroller. For sensors with microcontrollers set the device to operate in I²C mode allowing extensive configuration and monitoring. Additionally, an integrated oscillator (MCLK) output simplifies clock generation for IO-Link devices.

All 24V line interface pins (V₂₄, C/Q, DI, and GND) are reverse voltage protected, short circuit protected, hot-plug protected, and feature integrated ±1.2kV/500Ω surge protection.

Control Interface (I²C or Pin Mode)

Overview

The MAX22515 features a selectable control interface: I²C or pin mode control. Drive the I²C/PIN input high to set the device to operate in I²C mode. In this mode, connect SCL/100MA to the I²C clock generator of the microcontroller and connect SDA/WU to the SDA I/O on the microcontroller. Set the A0/CLKEN input high or low to set the I²C address of the device. See the [I²C Controller Interface](#) section for more information.

Drive the I²C/PIN input low to set the device to operate in pin mode.

I²C Mode

Set the I²C/PIN input high to configure the MAX22515 to operate in I²C mode control.

The MAX22515 I²C interface is available for extensive monitoring and configuration of the device. The C/Q driver configuration, driver current limit, and fault behaviors are all configurable in I²C mode. Additionally, extensive fault detection (driver overcurrent fault, thermal warning and thermal shutdown faults), and wake-up event detection allow the microcontroller to quickly determine the state of the device and react accordingly.

The MAX22515 can generate a wake-up pulse in I²C mode only.

Pin Mode

Set the I²C/PIN input low to operate the MAX22515 in pin mode. The MAX22515 has limited configurability in pin mode and includes the following nonconfigurable functionality:

- V₃₃ cannot be disabled.
- The C/Q rise time is 0.3μs and the fall time is 0.33μs.
- The C/Q driver current limit cannot be disabled.
 - Drive SCL/100MA high to enable the 100mA (typ) driver current limit.
 - Drive SCL/100MA low to enable the 200mA (typ) driver current limit.
- Autoretry functionality is enabled with a 500μs blanking time 50ms fixed off-time during overcurrent events.
- C/Q is the logic inverse of TX.
- RX is the logic inverse of C/Q.
- LI is the logic inverse of DI.
- Glitch filters on C/Q and DI receivers are disabled.
- Weak pullup and pulldown currents on C/Q are disabled.
- SDA/WU asserts low when a wake-up is detected on C/Q.
 - WU/IRQ does not assert when a wake-up is detected.
- WU/IRQ asserts during a driver fault condition or thermal overload condition or when V₂₄ is below the warning threshold voltage (V_{24_W}).
 - WU/IRQ deasserts when the fault condition is removed and when V₂₄ is above the warning threshold voltage.
- The MAX22515 cannot generate a wake-up pulse.
- The MCLK switching frequency is 14.74MHz (typ).

24V Interface

C/Q Driver Overcurrent Limiting

When a load attempts to draw more current than the current limit threshold that has been set, the C/Q driver actively limits the load current so a higher current does not flow. The MAX22515 features a selectable C/Q driver current limit in both I²C mode and in pin mode.

In I²C mode, select the C/Q driver current limit by setting the CL[1:0] bits in the CURRLIM register. Current limit thresholds can be set to 50mA (min), 100mA (min), 200mA (min), or 250mA (min).

In pin mode, select the C/Q driver current limit by setting the SCL/100MA input high or low. Drive SCL/100MA high to set the driver current limit to 100mA (min). Drive SCL/100MA low to set the current limit to 200mA (min).

C/Q Driver Continuous Current Limiting with Blanking Time and Autoretry

The MAX22515 features two overcurrent management functions to allow the C/Q driver to drive large loads without triggering a fault: blanking time and autoretry.

When the C/Q driver current exceeds the current limit threshold for a duration longer than the blanking time, a fault is generated. Loads that require large currents are often capacitive, incandescent lamps, or can be short circuits. When driving capacitive or lamp loads, ensure that the blanking time is long enough to charge up the required load.

- In I²C mode, the CQFAULT bit in the INTERRUPT register is set and, if the interrupt is not masked, the $\overline{WU/IRQ}$ output asserts.
- In pin mode, $\overline{WU/IRQ}$ asserts and deasserts when the fault condition is removed.

Select the blanking time in I²C mode by setting the CL_BL[1:0] bits in the CURRLIM register. Available blanking times are 128 μ s (typ), 500 μ s (typ), 1ms (typ), or 5ms (typ). The blanking time is fixed at 500 μ s (typ) when operating in pin mode.

When autoretry is enabled, the driver is automatically disabled after the blanking time and remains off for a set off-time. The driver is reenabled after the off-time. If the overcurrent condition is still present, the driver is disabled again after the blanking time and the cycle continues.

- In I²C mode, enable autoretry functionality by setting the AUTORETRYEN bit in the CURRLIM register. Select the driver off-time during autoretry by setting the TAROFF[1:0] bits in the CURRLIM register.
- In pin mode, autoretry functionality is enabled and the driver off-time is fixed as 50ms.

C/Q Driver Thermal Shutdown

The C/Q driver is automatically disabled when the driver junction temperature exceeds the +150°C (typ) driver thermal shutdown temperature. A fault condition is signaled after the set blanking time (and the auto-retry off period if enabled).

- In I²C mode, the CQFAULT bit in the INTERRUPT register is set and, if the fault is not masked (CQFAULTM = 0), $\overline{WU/IRQ}$ asserts.
- In pin mode, $\overline{WU/IRQ}$ asserts until the driver temperature falls below the thermal shutdown hysteresis.

If autoretry is disabled (I²C mode only) the driver is automatically reenabled when the driver temperature falls below 140°C (typ). If autoretry is enabled (AUTORETRYEN = 1), or the device is in pin mode, the MAX22515 waits for the autoretry delay and reenables the driver.

Receiver Threshold

Although the IO-Link standard defines device/sensor operation for a supply ranging between 18V and 30V, industrial sensors in the field commonly operate with supply voltages as low as 9V. The MAX22515 operates with a supply voltage between 8V and 36V. When the V₂₄ supply voltage is above 18V, the C/Q and DI receiver thresholds fall within the IO-Link required values. When V₂₄ is less than 18V, the MAX22515 scales the C/Q and DI receiver thresholds with respect to V₂₄, allowing receiver functionality down to the lowest supply voltage.

Wake-Up Detection

The MAX22515 detects a wake-up condition as a combination of current and a voltage event on the C/Q line when the driver is enabled in PNP, NPN, or push-pull mode. A wake-up event occurs when an IO-Link master forces a level on the C/Q line to the opposite logic-level and a current is sourced (or sinked) for 80 μ s (typ).

In I²C mode, the WUINT bit in the INTERRUPT register is set and, unless masked (WUIM = 1 in the IRQMASK register), $\overline{WU}/\overline{IRQ}$ asserts to indicate that a wake-up has been detected. Wake-up detection is enabled by default. Set the WUDIS bit in the CONTROL register to disable wake-up detection.

In pin mode, a wake-up event can be detected when TXEN is either high (driver enabled) or low (driver disabled). When the driver is enabled, a wake-up event is detected when the C/Q driver is forced to the opposite logic state and a current is sourced (or sinked) from the driver for 80 μ s (typ). When the driver is disabled, a wake-up event is detected when the C/Q input has the same polarity as the TX input for 80 μ s (typ). Wake-up detection is always enabled in pin mode and cannot be disabled. SDA/ \overline{WU} asserts low when a valid wake-up has been detected in pin mode. $\overline{WU}/\overline{IRQ}$ does not assert when a wake-up has been detected in pin mode.

The MAX22515 automatically ignores false wake-up events that can sometimes occur as a consequence of driving large capacitive or lamp loads where the time constant of charge-up is in the range of 80 μ s. No wake-up event is detected for the duration of the set blanking time after the C/Q driver changes logic state.

Wake-Up Pulse Generation (I²C Mode Only)

In I²C mode, the MAX22515 can generate a wake-up pulse.

To prepare the transceiver to generate a wake-up pulse, set the C/Q driver in receive mode (CQ_EN = 0 and TXEN = low) and set the TX input high. Set the WURQ bit in the WAKEUP register to generate the wake-up pulse.

When WURQ = 1, the MAX22515 samples the voltage level on the C/Q receiver. The device then enables the C/Q driver and pulls the C/Q line to the opposite polarity of the sampled voltage for 80 μ s (typ). The driver remains enabled and the line is driven back to the original polarity after the wake-up pulse duration. Following the on-time after wake-up delay (t_{ON_WU}), the driver is set to high impedance. The MAX22515 continues to ignore signals on TX and TXEN and holds the driver in a high impedance state for the high-impedance time after wake-up delay (t_{DIS_WU}), after which the microcontroller can initiate the normal IO-Link communication sequence. See [Figure 6](#).

Ensure that the CQSLEW[1:0] bits in the CQCONFIG register are set to 00 to ensure that driver rise and fall times are as short as possible.

EN Input/Power OK (POK) Output

The EN/POK input is a dual function open-drain logic input/output, functioning as an active-high enable input and a power-OK (POK) output. Connect EN/POK to V_L with a 10k Ω resistor. To avoid contention, drive EN/POK with an open-drain output.

Drive EN/POK low to set the MAX22515 in reset mode. The C/Q driver is disabled and the registers are reset (if using I²C mode) when EN/POK is low. I²C communication is available while EN/POK is low if V_L is present.

The MAX22515 asserts EN/POK low when the V_5 voltage falls below the V_5 POK threshold. The C/Q driver is disabled and the registers are reset (if using I²C mode) when EN/POK is low. The MAX22515 deasserts EN/POK 4ms (typ) after the V_5 voltage rises above the POK threshold.

Protection

Reverse Polarity Protection

The MAX22515 is protected against reverse polarity connections on the C/Q, DI, V₂₄, and GND pins. Any combination of these pins can be connected to a voltage in the range of -36V to +36V. This results in a current flow of less than 500µA. Note that the maximum voltage between any pins should not exceed [Absolute Maximum Ratings](#).

Thermal Shutdown

The MAX22515 enters thermal shutdown when the average die temperature exceeds the +160°C (typ) thermal shutdown threshold. The C/Q driver is switched off during thermal shutdown. The V₅ and V₃₃ regulators remain on during thermal shutdown and I²C communication is available, if enabled. When the average die temperature falls below the 145°C (typ) thermal shutdown hysteresis, the device exits thermal shutdown.

In I²C mode, the THSHUTD bit in the STATUS register and the THSHUTINT bit in the INTERRUPT register are set, and if not masked (THSHUTM = 0 in the IRQMASK register), $\overline{WU/IRQ}$ asserts. THSHUTD is cleared when the MAX22515 exits thermal shutdown. Read the INTERRUPT register to clear the THSHUTINT bit and deassert $\overline{WU/IRQ}$.

In pin mode, $\overline{WU/IRQ}$ asserts when the MAX22515 enters thermal shutdown and deasserts when it exits thermal shutdown.

POR and Register Corruption Check (I²C Mode Only)

The MAX22515 performs on-going checks of all register bits. A register is corrupted when the value is changed by an external event (for example, an ESD discharge, etc.). When a corrupt register bit is detected, the CORR_REG bit in the STATUS2 register is set, the NOTREADY bit in the INTERRUPT register is set, and the $\overline{WU/IRQ}$ output is asserted. The C/Q driver is disabled when the NOTREADY bit is set.

The microcontroller must rewrite correct values to all of the registers after the CORR_REG bit has been set. The CORR_REG bit is automatically cleared when the registers have been rewritten to their preevent cycle values. Once the CORR_REG bit is cleared, read the INTERRUPT register to clear the NOTREADY bit and deassert $\overline{WU/IRQ}$.

I²C Controller Interface

Overview

Drive the I²C/ \overline{PIN} pin high to set the MAX22515 to operate with the I²C control interface. The I²C interface supports fast mode plus with a clock frequency up to 1MHz and features SDA stuck protection. SCL/100MA and SDA/ \overline{WU} require pullup resistors to V_L or an external voltage for I²C communication.

The MAX22515 supports both burst and single-byte read and write functionality.

I²C Slave Address

Set the A0/CLKEN pin to set the 7-bit slave address for I²C communication. The first 6 bits (MSBs) of the slave address are factory-programmed and is always 011010. Connect A0/CLKEN to V_L or GND to set the LSB of the address. The address is defined as the 7 MSBs followed by a read/write bit. Set the read/write bit to 1 to configure the MAX22515 to read mode. Set the read/write bit to 0 to configure the device for write mode. The address is the first byte of information sent to the device after the START condition.

I²C Address Map

I²C Byte Write

With this operation the master sends an address and 1 or 2 data bytes to the slave device ([Figure 8](#)). The write byte procedure is as follows:

- 1) The master sends a START condition.
- 2) The master sends the 7-bit slave ID plus a write bit (low).
- 3) The addressed slave asserts an ACK on the data line.
- 4) The master sends the 8-bit register address.
- 5) The active slave asserts an ACK on the data line only if the address is valid (NACK if not).
- 6) The master sends the 8-bit data byte.
- 7) The slave asserts an ACK on the data line.
- 8) The master generates a STOP condition.

Table 1. I²C Address Map

A0/CLKEN	READ/WRITE	I ² C ADDRESS
0	W	0x68
	R	0x69
1	W	0x6A
	R	0x6B

I²C Byte Read

With this operation the master sends an address and receives 1 or 2 data bytes from the slave device (Figure 9). The read byte procedure is as follows:

- 1) The master sends a START condition.
- 2) The master sends the 7-bit slave ID plus a write bit (low).
- 3) The addressed slave asserts an ACK on the data line.
- 4) The master sends the 8-bit register address.
- 5) The active slave asserts an ACK on the data line only if the address is valid (NACK if not).
- 6) The master sends a repeated START (Sr).
- 7) The master sends the 7-bit slave ID plus a read bit (high).
- 8) The slave asserts an ACK on the data line.
- 9) The slave sends 8 data bits.
- 10) The master asserts a NACK on the data line.
- 11) The master generates a STOP condition.

SDA Stuck Protection

A stuck bus occurs in I²C communication when a slave receives some communication but does not receive a stop (P) or repeated start (Sr) that signals to the slave to release the bus. When this happens, the data line (SDA/WU) is held low by the slave and no further communication can occur on the bus until it is released. The MAX22515 features an internal timer that monitors the data line to protect against this situation. If SDA/WU is held low for more than 1.1ms (typ), the MAX22515 releases the data line high, resuming normal communication. This bus protection limits the minimum I²C clock frequency to 10kHz.

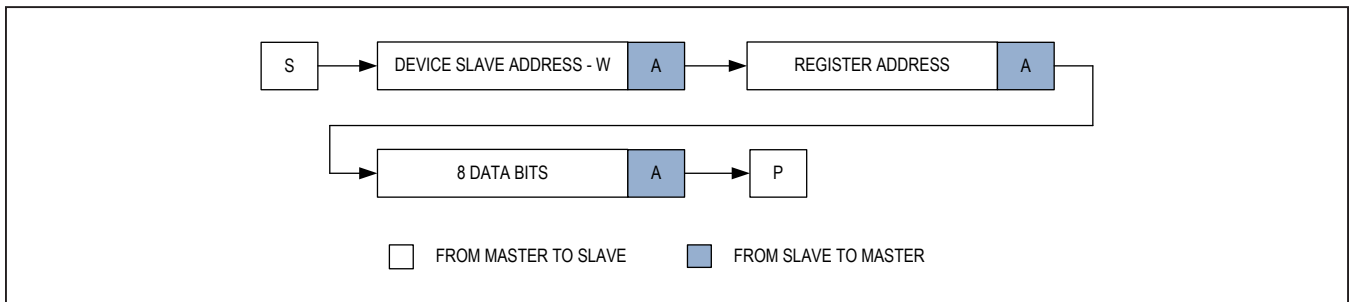


Figure 8. I²C Byte Write

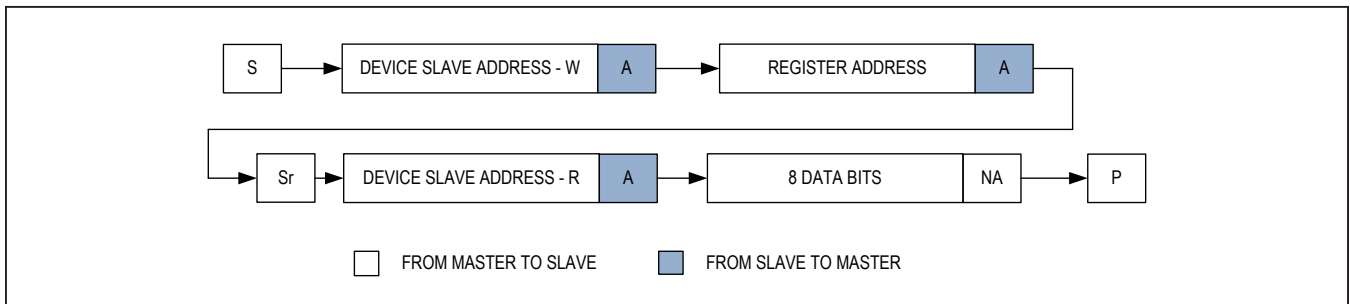


Figure 9. I²C Byte Read

Register Map

ADDRESS	NAME	MSB							LSB
Functional									
0x00	INTERRUPT (0x00)[7:0]	NOT-READY	WUINT	–	CQFAULTINT	V24WINT	UV24INT	THSHUTINT	THERMWINT
0x01	IRQMASK (0x01)[7:0]	–	WUM	–	CQFAULTM	V24WM	UV24M	THSHUTM	THERMWM
0x02	STATUS1 (0x02)[7:0]	CQLVL	DILVL	–	CQFAULT	V24WARN	UV24	THSHUTD	THERMW
0x03	STATUS2 (0x03)[7:0]	CORR_REG	–	–	–	–	–	–	–
0x04	MODE (0x04)[7:0]	RST	–	–	–	–	–	–	–
0x05	CURRLIM (0x05)[7:0]	CL[1:0]		CLDIS	CL_BL[1:0]		TAR[1:0]		AUTORETRYEN
0x06	CONTROL (0x06)[7:0]	LDO-33DIS	WUDIS	DIDIS	DIFILTER	RXDIS	RXFILTER	–	CQ_Q
0x07	CQCONFIG (0x07)[7:0]	CQSLEW[1:0]		CQ_PD	CQ_PU	CQ_NPN	CQ_PP	INVCQ	CQ_EN
0x08	DICONFIG (0x08)[7:0]	–	–	–	–	–	–	INVDI	LIDIS
0x09	CLKCONFIG (0x09)[7:0]	ENCLKTRIM	–	–	–	CLKDIV[2:0]			MCLKDIS
0x0A	CLKTRIM (0x0A)[7:0]	CKTRIM[7:0]							
0x0B	WAKEUP (0x0B)[7:0]	WURQ	–	–	–	–	–	–	–
0x0C	CHIPID (0x0C)[7:0]	CHIPID[7:0]							

- Reserved. Do not use.

Register Details

INTERRUPT (0x00)

BIT	7	6	5	4	3	2	1	0
Field	NOTREADY	WUINT	–	CQFAUL- TINT	V24WINT	UV24INT	THSHU- TINT	THERM- WINT
Reset	0	0	–	0	0	0	0	0
Access Type	Read Clears All	Read Clears All	–	Read Clears All	Read Clears All	Read Clears All	Read Clears All	Read Clears All

BITFIELD	BITS	DESCRIPTION
NOTREADY	7	0 = The MAX22515 is operating normally. 1 = Any of the following conditions has occurred since the last INTERRUPT register read: * The V ₅ supply voltage dropped below its UVLO threshold and the registers were reset. * A power-up occurred and the registers have been reset. * At least one register has been corrupted due to an external event (not POR). The NOTREADY interrupt cannot be masked.
WUINT	6	0 = No wake-up event has been detected. 1 = An IO-Link wake-up event has been detected on the C/Q line since the last INTERRUPT register read.
CQFAULTINT	4	0 = C/Q driver operating normally. 1 = Overcurrent/overload condition or driver thermal shutdown event has occurred on the C/Q driver since the last INTERRUPT register read.
V24WINT	3	0 = V ₂₄ is above 16V (typ). 1 = V ₂₄ voltage has fallen below 16V (typ) since the last INTERRUPT register read.
UV24INT	2	0 = V ₂₄ is above the 7V (typ) undervoltage threshold (UVLO). 1 = The V ₂₄ voltage has fallen below the 6V (typ) undervoltage threshold since the last INTERRUPT register read.
THSHUTINT	1	0 = The MAX22515 has not entered thermal shutdown. 1 = The MAX22515 has entered thermal shutdown since the last INTERRUPT register read.
THERMWINT	0	0 = The MAX22515 temperature has not risen above the thermal warning temperature threshold. 1 = The MAX22515 temperature has risen above the thermal warning temperature threshold since the last INTERRUPT register read.

IRQMASK (0x01)

BIT	7	6	5	4	3	2	1	0
Field	–	WUM	–	CQFAULTM	V24WWM	UV24M	THSHUTM	THERMWM
Reset	–	0	–	0	0	0	0	0
Access Type	–	Write, Read	–	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION
WUM	6	0 = $\overline{WU/IRQ}$ asserts when the WUINT bit in the INTERRUPT register is set. 1 = $\overline{WU/IRQ}$ asserts for 200 μ s (typ) and then deasserts after a valid wake-up condition is detected.
CQFAULTM	4	0 = $\overline{WU/IRQ}$ asserts when the CQFAULT bit in the INTERRUPT register is set. 1 = $\overline{WU/IRQ}$ does not assert when the CQFAULT bit in the INTERRUPT register is set.
V24WWM	3	0 = $\overline{WU/IRQ}$ asserts when the V24WINT bit in the INTERRUPT register is set. 1 = $\overline{WU/IRQ}$ does not assert when the V24WINT bit in the INTERRUPT register is set.
UV24M	2	0 = $\overline{WU/IRQ}$ asserts when the UV24INT bit in the INTERRUPT register is set. 1 = $\overline{WU/IRQ}$ does not assert when the UV24INT bit in the INTERRUPT register is set.
THSHUTM	1	0 = $\overline{WU/IRQ}$ asserts when the THSHUTINT bit in the INTERRUPT register is set. 1 = $\overline{WU/IRQ}$ does not assert when the THSHUTINT bit in the INTERRUPT register is set.
THERMWM	0	0 = $\overline{WU/IRQ}$ asserts when the THERMWINT bit in the INTERRUPT register is set. 1 = $\overline{WU/IRQ}$ does not assert when the THERMWINT bit in the INTERRUPT register is set.

STATUS1 (0x02)

BIT	7	6	5	4	3	2	1	0
Field	CQLVL	DILVL	–	CQFAULT	V24WARN	UV24	THSHUTD	THERMW
Reset		0	–	0	0	0	0	0
Access Type	Read Only	Read Only	–	Read Only	Read Only	Read Only	Read Only	Read Only

BITFIELD	BITS	DESCRIPTION
CQLVL	7	0 = C/Q is high. 1 = C/Q is low.
DILVL	6	0 = DI is high. 1 = DI is low.
CQFAULT	4	0 = No fault on the C/Q driver. 1 = Overcurrent or thermal overload fault on the C/Q driver.
V24WARN	3	0 = V_{24} is above the 16V (typ) warning threshold. 1 = V_{24} is below the 16V (typ) warning threshold.
UV24	2	0 = V_{24} is above the 7V (typ) rising undervoltage lockout (UVLO) threshold. 1 = V_{24} is below the 6V (typ) falling UVLO threshold.
THSHUTD	1	0 = The die temperature is below the thermal shutdown threshold. 1 = The die temperature is above the thermal shutdown threshold. The MAX22515 is in thermal shutdown.
THERMW	0	0 = The die temperature is below the 125°C (typ, falling) warning threshold. 1 = The die temperature is above the 140°C (typ, rising) warning threshold.

STATUS2 (0x03)

BIT	7	6	5	4	3	2	1	0
Field	CORR_REG	–	–	–	–	–	–	–
Reset	0	–	–	–	–	–	–	–
Access Type	Read Only	–	–	–	–	–	–	–

BITFIELD	BITS	DESCRIPTION
CORR_REG	7	0 = All register values are correct. 1 = Register values are corrupted. C/Q is disabled and RX and LI are high impedance when CORR_REG = 1. V ₃₃ is forced on and MCLK is enabled at switching at 14.74MHz (typ).

MODE (0x04)

BIT	7	6	5	4	3	2	1	0
Field	RST	–	–	–	–	–	–	–
Reset	0	–	–	–	–	–	–	–
Access Type	Write Only Clears All	–	–	–	–	–	–	–

BITFIELD	BITS	DESCRIPTION
RST	7	0 = Registers are not in reset state. 1 = Set all registers to their default state. RST clears automatically.

CURRLIM (0x05)

BIT	7	6	5	4	3	2	1	0
Field	CL[1:0]		CLDIS	CL_BL[1:0]		TAR[1:0]		AUTO-RETRYEN
Reset	00		0	00		00		0
Access Type	Write, Read		Write, Read	Write, Read		Write, Read		Write, Read

BITFIELD	BITS	DESCRIPTION
CL	7:6	CL[1:0] bits set the active current limit levels for the C/Q driver when CLDIS = 0. 00 = 50mA (min) current limit 01 = 100mA (min) current limit 10 = 200mA (min) current limit 11 = 250mA (min) current limit
CLDIS	5	0 = The C/Q driver current limit is enabled. The current limit is set by the CL[1:0] bits. 1 = The C/Q driver current limit is disabled. The C/Q driver current can exceed 500mA (min).
CL_BL	4:3	CL_BL[1:0] set the blanking time for the C/Q driver. 00 = 128µs (typ) 01 = 500µs (typ) 10 = 1ms (typ) 11 = 5ms (typ)
TAR	2:1	The TAR[1:0] bits set the fixed off-time for the C/Q driver after an overcurrent or driver thermal shutdown fault has been generated and autoretry functionality is enabled (AUTOETRYEN = 1). The driver is automatically reenabled after the fixed off-time delay. 00 = 50ms (typ) 01 = 100ms (typ) 10 = 200ms (typ) 11 = 500ms (typ)
AUTO RETRYEN	0	Enable/disable autoretry for overcurrent and overtemperature events. 0 = Autoretry is disabled on the C/Q driver. When AUTOETRYEN = 0, the C/Q driver is only turned-off due to thermal overload. 1 = Autoretry is enabled on the C/Q driver. When a fault is signaled on the driver, the driver is disabled for the selected off-time and then automatically reenabled.

CONTROL (0x06)

BIT	7	6	5	4	3	2	1	0
Field	LDO33DIS	WUDIS	DIDIS	DIFILTER	RXDIS	RXFILTER	–	CQ_Q
Reset	0	0	0	0	0	0	–	0
Access Type	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read	–	Write, Read

BITFIELD	BITS	DESCRIPTION
LDO33DIS	7	0 = V ₃₃ linear regulator is enabled. 1 = V ₃₃ linear regulator is disabled.
WUDIS	6	0 = IO-Link wake-up detection is enabled. 1 = IO-Link wake-up detection is disabled.
DIDIS	5	0 = DI receiver is enabled. 1 = DI receiver is disabled. DI input current is reduced when DIDIS = 1.
DIFILTER	4	0 = The 1μs (typ) glitch filter on the DI receiver is disabled. 1 = The 1μs (typ) glitch filter on the DI receiver is enabled.
RXDIS	3	0 = RX logic output is enabled. 1 = RX logic output is disabled. C/Q input current is reduced when RXDIS = 1. RX is high impedance when RXDIS = 1.
RXFILTER	2	0 = The 1μs (typ) glitch filter on the C/Q receiver is disabled. 1 = The 1μs (typ) glitch filter on the C/Q receiver is enabled.
CQ_Q	0	Use the CQ_Q bit to control the C/Q driver output. See Table 2 for more information.

CQCONFIG (0x07)

BIT	7	6	5	4	3	2	1	0
Field	CQSLEW[1:0]		CQ_PD	CQ_PU	CQ_NPN	CQ_PP	INVCQ	CQ_EN
Reset	00		0	0	0	0	0	0
Access Type	Write, Read		Write, Read	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION
CQSLEW	7:6	The CQSLEW[1:0] bits set the typical rising and falling times on the C/Q driver. 00 = 0.15 μ s (typ, rising), 0.16 μ s (typ, falling) 01 = 0.3 μ s (typ, rising), 0.33 μ s (typ, falling) 10 = 0.9 μ s (typ, rising), 0.8 μ s (typ, falling) 11 = 3.3 μ s (typ, rising), 3.3 μ s (typ, falling)
CQ_PD	5	0 = The 300 μ A (typ) weak pulldown current sink on the C/Q driver is disabled. 1 = The 300 μ A (typ) weak pulldown current sink on the C/Q driver is enabled.
CQ_PU	4	0 = The 300 μ A (typ) weak pullup current source on the C/Q driver is disabled. 1 = The 300 μ A (typ) weak pullup current source on the C/Q driver is enabled.
CQ_NPN	3	0 = The C/Q driver is in PNP mode (CQ_PP = 0) or push-pull mode (CQ_PP = 1). 1 = The C/Q driver is in NPN mode (CQ_PP = 0) or push-pull mode (CQ_PP = 1).
CQ_PP	2	0 = The C/Q driver is in PNP mode (CQ_NPN = 0) or NPN mode (CQ_NPN = 1). 1 = The C/Q driver is in push-pull mode.
INVCQ	1	0 = The C/Q logic is inverted compared to TX and RX. 1 = The C/Q logic is the same as TX and RX.
CQ_EN	0	0 = The C/Q driver is disabled. 1 = The C/Q driver is enabled.

DICONFIG (0x08)

BIT	7	6	5	4	3	2	1	0
Field	–	–	–	–	–	–	INVDI	LIDIS
Reset	–	–	–	–	–	–	0	0
Access Type	–	–	–	–	–	–	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION
INVDI	1	0 = The DI logic is inverted compared to LI. 1 = The DI logic is the same as LI.
LIDIS	0	0 = LI is enabled. 1 = LI is disabled. LI is high impedance when disabled.

CLKCONFIG (0x09)

BIT	7	6	5	4	3	2	1	0
Field	ENCLK-TRIM	–	–	–	CLKDIV[2:0]			MCLKDIS
Reset	0	–	–	–	000			0
Access Type	Write, Read	–	–	–	Write, Read			Write, Read

BITFIELD	BITS	DESCRIPTION
ENCLKTRIM	7	0 = Fine trimming of the MCLK frequency is disabled. 1 = Fine trimming of the MCLK frequency is enabled. Set the bits in the CLKTRIM register to trim the MCLK frequency.
CLKDIV	3:1	The CLKDIV[2:0] bits set the internal clock divider ratio. 000 = MCLK frequency is 3.686MHz (typ). 001 = MCLK frequency is 7.373MHz (typ). 010 = MCLK frequency is 14.74MHz (typ). 011 = MCLK frequency is 29.49MHz (typ). 100 = MCLK frequency is 1.843MHz (typ).
MCLKDIS	0	0 = MCLK is enabled. 1 = MCLK is disabled. MCLK is high impedance when disabled.

CLKTRIM (0x0A)

BIT	7	6	5	4	3	2	1	0
Field	CKTRIM[7:0]							
Reset	0							
Access Type	Write, Read							

BITFIELD	BITS	DESCRIPTION
CKTRIM	7:0	The CKTRIM[7:0] bits are used to trim the internally generated MCLK frequency when ENCLKTRIM = 1. The bits are binary coded, centered to 0 from 0x80 for -3% to 0xF0 for +3%.

WAKEUP (0x0B)

BIT	7	6	5	4	3	2	1	0
Field	WURQ	–	–	–	–	–	–	–
Reset	0	–	–	–	–	–	–	–
Access Type	Write, Read	–	–	–	–	–	–	–

BITFIELD	BITS	DESCRIPTION
WURQ	7	0 = No wake-up pulse is generated by the MAX22515. 1 = Generate wake-up pulse on the C/Q line.

CHIPID (0x0C)

BIT	7	6	5	4	3	2	1	0
Field	CHIPID[7:0]							
Reset	0b00000010							
Access Type	Read only							

BITFIELD	BITS	DESCRIPTION
CHIPID	7:0	The CHIPID[7:0] bits identify the revision of the MAX22515.

Applications Information

MCLK Microcontroller Clocking

The MCLK output produces a clock that can be used for UART clocking.

Select the frequency of the MCLK output (in I²C mode) by setting the CLKDIV[2:0] bits in the CLKCONFIG register. Available MCLK frequencies are 1.843MHz (typ), 3.686MHz (typ), 7.373MHz (typ), 14.74MHz (typ), and 29.49MHz (typ). The MCLK frequency can be further adjusted by setting the ENCKTRIM bit in the CLKCONFIG register to 1 and writing the CKTRIM bits in the CLKTRIM register.

MCLK is enabled by default and the switching frequency is 14.74MHz (typ).

In pin mode, the MCLK output frequency cannot be changed.

MCLK voltage output levels are referenced to the V_L logic supply.

EMC Protection

The MAX22515 features integrated surge protection of ±1.2kV/500Ω for 8μs/20μs surge line-to-line and line-to-ground on the C/Q, DI, V₂₄, and GND pins.

External TVS diodes are required to meet higher levels of surge protection. Ensure that the TVS diode peak clamping voltage is within the [Absolute Maximum Ratings](#) voltage.

Power Dissipation and Thermal Considerations

Ensure that the total power dissipation in the MAX22515 is less than the limit in the [Absolute Maximum Ratings](#). Total power dissipation for the MAX22515 is calculated using the following equation:

$$P_{TOTAL} = P_Q + P_{V5} + P_{V33} + P_{C/Q}$$

where:

P_Q = Quiescent power dissipated in MAX22515

P_{C/Q} = Power dissipated in the C/Q driver

P_{V33} and P_{V5} = Power dissipated by the internal linear regulators

Quiescent power dissipated in the MAX22515 is calculated as:

$$P_Q = [I_{24} \times V_{24(max)}] + [I_5 \times V_5]$$

Power dissipated in the C/Q driver is calculated as:

$$P_{C/Q} = I_{C/Q(max)}^2 \times R_{ON}$$

I_{C/Q} is the load current driven by the C/Q driver and R_{ON} is the driver on-resistance.

Power dissipated in the 5V linear regulator (V₅) is calculated as:

$$P_{V5} = (V_{LIN} - V_5) \times I_{5LOAD}$$

I_{5LOAD} includes both the load current on the V₅ regulator and the 3.3V regulator.

Power dissipated in the 3.3V linear regulator (V₃₃) is calculated as:

$$P_{V33} = 1.7V \times I_{33LOAD}$$

I_{33LOAD} is the load on the 3.3V regulator.

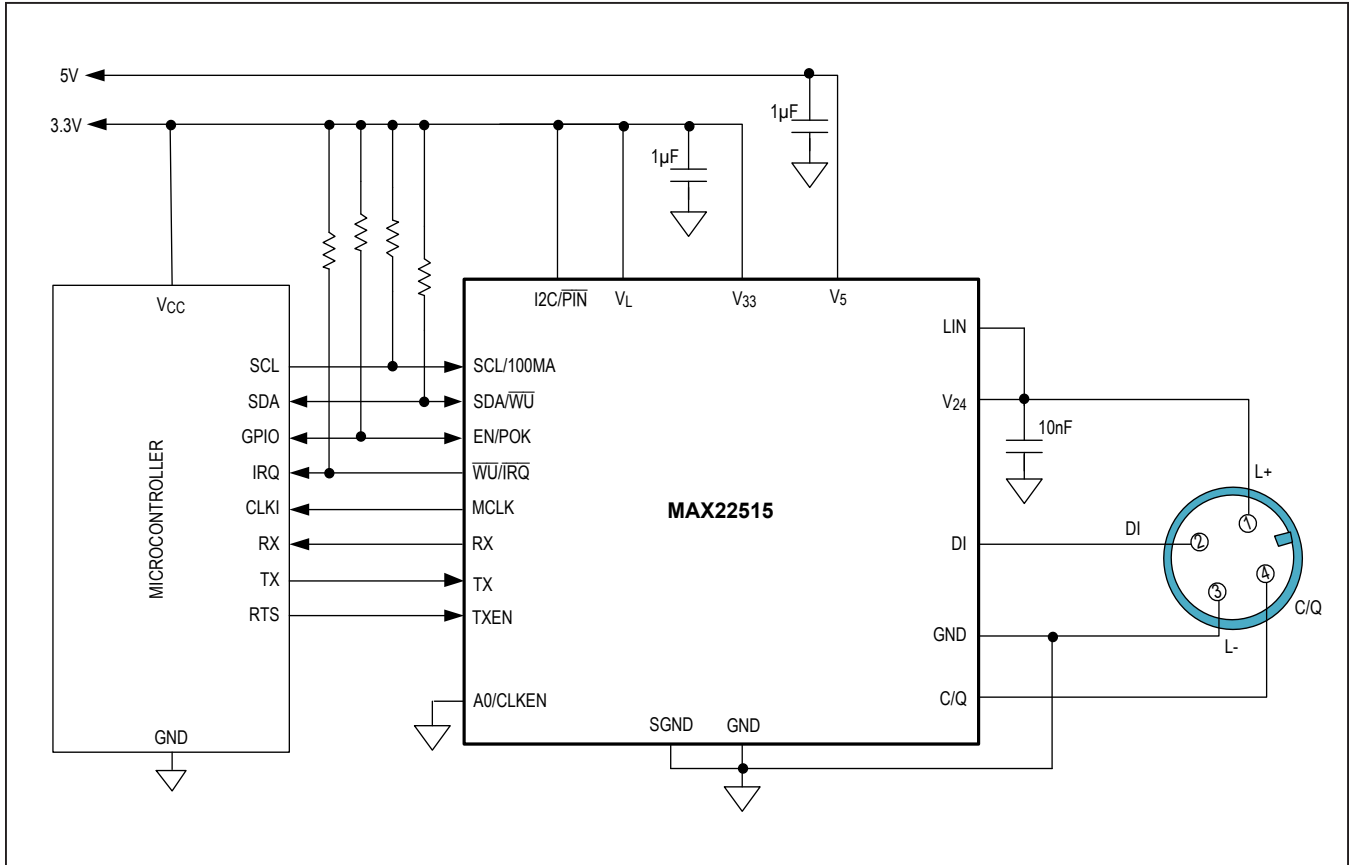
Table 2. C/Q Control

CQ_EN	TXEN	TX	CQ_Q	CQ		
				NPN	PNP	PP
0	X	X	X	Z	Z	Z
0	L	L	0	Z	Z	Z
			1	Z	H	H
		H	0	Z	Z	Z
			1	Z	H	H
	H	L	0	Z	H	H
			1	Z	H	H
		H	0	L	Z	L
			1	Z	H	H

X = Don't Care, Z = High Impedance

Typical Application Circuits

I²C Application



Ordering Information

PART NUMBER	TEMP RANGE	PIN-PACKAGE	BALL PITCH
MAX22515ATG+	-40°C to +125°C	24 TQFN-EP	—
MAX22515ATG+T	-40°C to +125°C	24 TQFN-EP	—
MAX22515AWP+	-40°C to +125°C	20 WLP	0.5mm
MAX22515AWP+T	-40°C to +125°C	20 WLP	0.5mm

+ Denotes a lead(Pb)-free/RoHS-compliant package.
 T = Tape and reel.

Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	7/19	Initial release	—
1	7/19	Marked MAX22515ATG+ and MAX22515ATG+T as future parts in the <i>Ordering Information</i> table	34
2	9/19	Updated Outline Number, Figure 5; corrected typo	1, 3, 12
3	9/19	Removed future product designation from MAX22515ATG+ and MAX22515ATG+T	34
4	10/19	Updated the <i>Electrical Characteristics</i> section	5

For pricing, delivery, and ordering information, please visit Maxim Integrated's online storefront at <https://www.maximintegrated.com/en/storefront/storefront.html>.

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